

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10/008,646	PLATT, CHRISTOPHER LOREN
	Examiner	Art Unit
	Kevin M Bernatz	1773
		Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-2002/0181170	12-2002	Lin et al.	360/324.11
B	US-5,942,342	08-1999	Hikosaka et al.	428/694R
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
U	Tanaka, A., Shimizu, Y., Kishi, H., Nagaska, K., Kanai, H., and M. Oshikik IEEE Trans. Mag., 35(2), 1999, 700 - 705.		
V			
W			
X			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.